



Shantou Huashan Electronic Devices Co.,Ltd.

HFP15N06

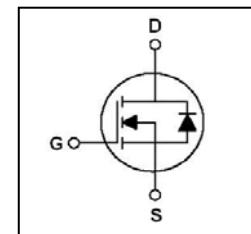
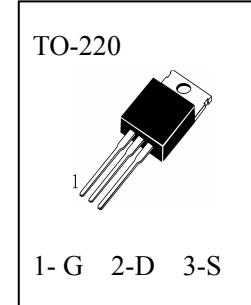
N-Channel Enhancement Mode Field Effect Transistor

■ Applications

- Servo motor control.
- Power MOSFET gate drivers.
- DC/DC converters
- Other switching applications.

■ Features

- 15A, 60V(See Note), $R_{DS(on)} < 100\text{mV}\Omega$ @ $V_{GS} = 5\text{V}$
- Fast switching
- 100% avalanche tested
- Minimize input capacitance and gate charge
- Exceptional dv/dt capability



■ Maximum Ratings (Ta=25°C unless otherwise specified)

T _{stg} —— Storage Temperature -----	-55~150 °C
T _j —— Operating Junction Temperature -----	150 °C
V _{DSS} —— Drain-Source Voltage -----	60V
V _{GSS} —— Gate-Source Voltage -----	±15V
I _D —— Drain Current (Continuous)(T _c =25°C) -----	15A
I _{DM} —— Pulsed Drain Current (Note 1)-----	60A
P _D —— Maximum Power Dissipation (T _c =25°C) -----	60W
E _{AS} —— Pulsed Avalanche Energy (Note 2) -----	50mJ

■ Thermal Characteristics

Symbol	Items	TO-220	Unit
R _{thj-case}	Thermal Resistance Junction-case	Max 4.38	°C/W
R _{thj-amb}	Thermal Resistance Junction-ambient	Max 58	°C/W



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■ Electrical Characteristics (Ta=25°C unless otherwise specified)

Symbol	Items	Min.	Typ.	Max.	Unit	Conditions
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	60			V	I _D =250μA , V _{GS} =0V
I _{DSS}	Zero Gate Voltage Drain Current		250	μA	V _{DS} =60V, V _{GS} =0V	
I _{GSS}	Gate – Body Leakage		±100	nA	V _{GS} = ±15V , V _{DS} =0V	
On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	1.0	1.75	2.5	V	V _{DS} = V _{GS} , I _D =250μA
R _{DS(on)}	Static Drain-Source On-Resistance		100	mΩ	V _{GS} =5V, I _D =7.5A (Note 3)	
Dynamic Characteristics and Switching Characteristics						
C _{iss}	Input Capacitance		700	950	pF	V _{DS} = 25V, V _{GS} = 0V, f = 1.0 MHz
C _{oss}	Output Capacitance		230	310	pF	
C _{rss}	Reverse Transfer Capacitance		80	110	pF	
t _{d(on)}	Turn - On Delay Time		15	60	nS	
t _r	Rise Time		160	200	nS	V _{DS} = 30V, V _{GS} = 5V, ID=7.5A,R _G = 4.7 Ω (Note 3)
t _{d(off)}	Turn - Off Delay Time		52	80	nS	
t _f	Fall Time		100	140	nS	
Q _g	Total Gate Charge		18	30	nC	V _{DS} =40V, ID=15A, V _{GS} = 5V (Note 3)
Q _{gs}	Gate–Source Charge		8		nC	
Q _{gd}	Gate–Drain Charge		9		nC	
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Continuous Source–Drain Diode Forward Current			15	A	
I _{SM}	Pulsed Drain-Source Diode Forward Current			60	A	
V _{SD}	Source–Drain Diode Forward On–Voltage			1.5	V	I _S =15A,V _{GS} =0(Note 3)

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. EAS condition: T_j=25°C, VDD=25V, ID=15A, L=0.5mH
3. Pulse Test: Pulse width≤300μS, Duty Cycle≤1.5%



■ Typical Characteristics

TEST CIRCUITS AND WAVEFORMS

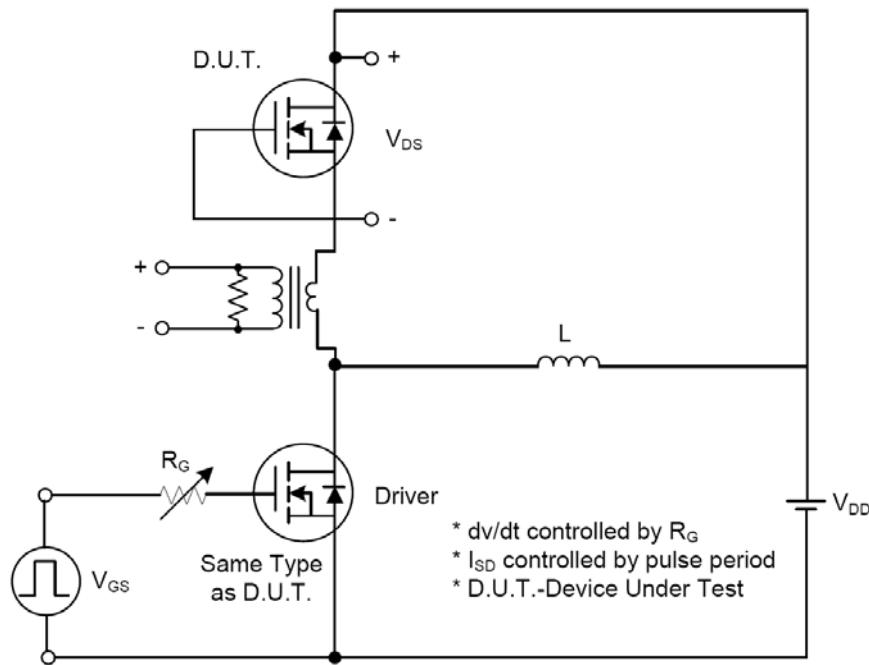


Fig. 1A Peak Diode Recovery dv/dt Test Circuit

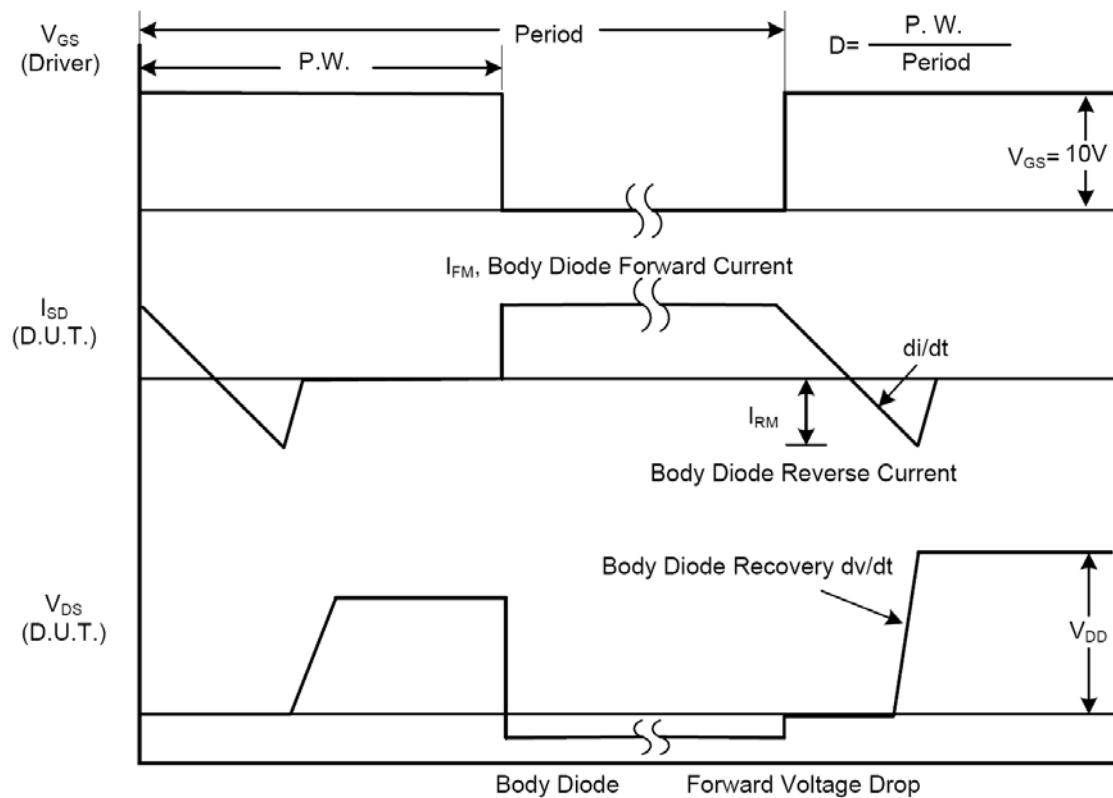


Fig. 1B Peak Diode Recovery dv/dt Waveforms



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■ Typical Characteristics

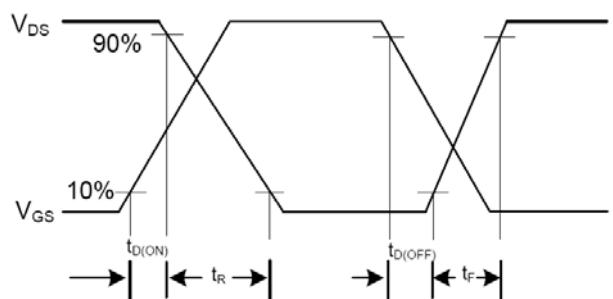
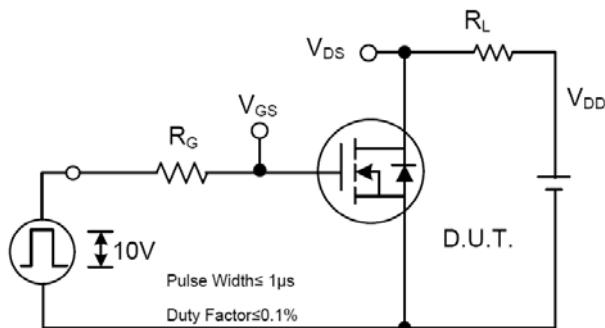


Fig. 2A Switching Test Circuit

Fig. 2B Switching Waveforms

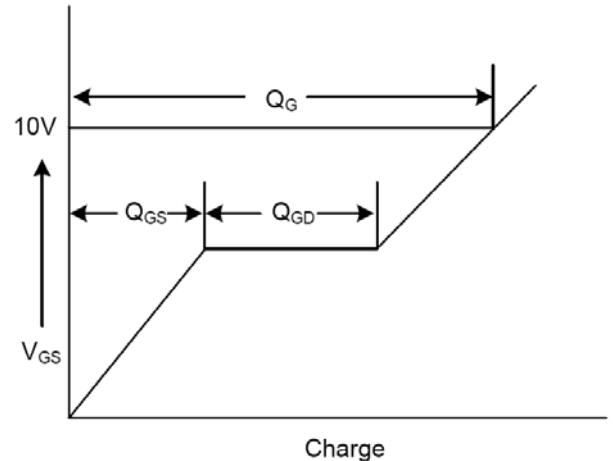
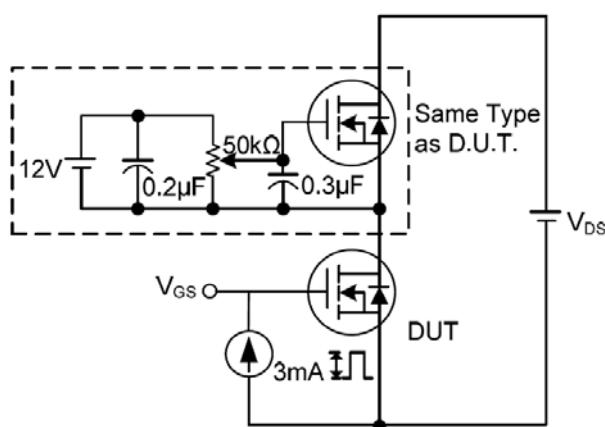


Fig. 3A Gate Charge Test Circuit

Fig. 3B Gate Charge Waveform

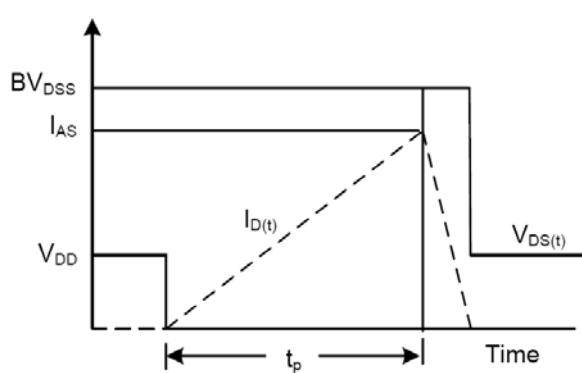
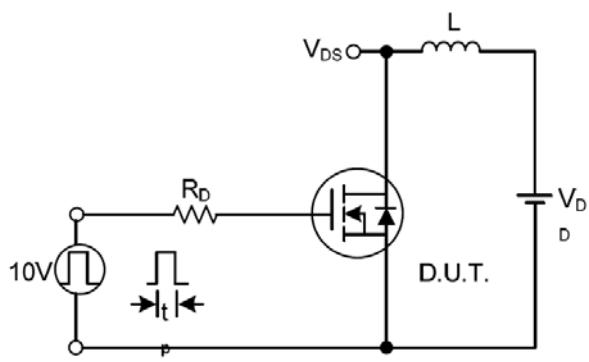


Fig. 4A Unclamped Inductive Switching Test Circuit

Fig. 4B Unclamped Inductive Switching Waveforms



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■ Typical Characteristics

